



DESCRIPTION

$V_{DS}=30V$

$V_{GS}=\pm 20V$

$I_D(A)=0.56A$

$R_{DS(ON)}, V_{GS}@4.0V, I_{DS}@10mA = 1\Omega$

$R_{DS(ON)}, V_{GS}@2.5V, I_{DS}@10mA = 1.5\Omega$

The AM4003 is available in SOT-23S package.

ORDERING INFORMATION

Package Type	Part Number	
SOT-23S SPQ: 3,000pcs/Reel	E3S	AM4003E3SR
		AM4003E3SVR
Note	V: Halogen free Package R: Tape & Reel	
AiT provides all RoHS products		

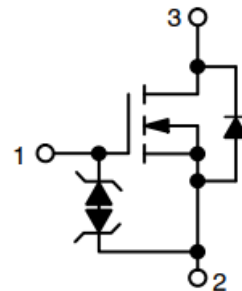
FEATURES

- Low gate voltage threshold($V_{GS(th)}$)to facilitate drive circuit design
- Low gate charge for fast switching
- ESD protected gate
- Minimum breakdown voltage rating of 30V
- Available in SOT-23S package

APPLICATION

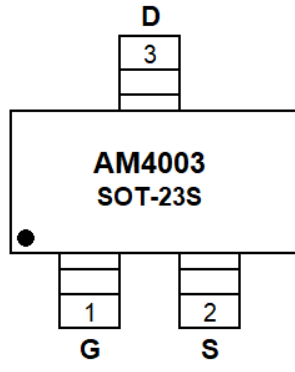
- Level shifters
- Level switches
- Low side load switches
- Portable applications

N CHANNEL MOSFET





PIN DESCRIPTION



Top View

Pin #	Symbol	Function
1	G	Gate
2	S	Source
3	D	Drain



ABSOLUTE MAXIMUM RATINGS

T_A=25°C

V _{DSS} , Drain-to-Source Voltage		30V
V _{GS} , Gate-to-Source Voltage – Continuous		±20V
I _D , Continuous Drain Current ^{NOTE1} Steady State	T _A = 25°C	0.5A
	T _A = 85°C	0.37A
I _D , Continuous Drain Current ^{NOTE1} t<10s	T _A = 25°C	0.56A
	T _A = 85°C	0.4A
I _{DM} , Pulsed Drain Current(tp=10µs)		1.7A
I _S , Continuous Source Current (Body Diode)		1A
P _D , Maximum Power Dissipation ^{NOTE1}	Steady State	0.69W
	t<5s	0.83W
T _J , T _{STG} , Junction and Storage Temperature		-55 ~ +150°C
T _L , Maximum Temperature for Soldering Purposes		260°C

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL CHARACTERISTICS

Parameter		Symbol	Limit	Units
Thermal Resistance, Junction-to-Ambient ^{NOTE1}	Steady State	R _{θJA}	180	°C/W
	t < 10s		150	



ELECTRICAL CHARACTERISTICS

T_A=25°C

Parameter	Symbol	Conditions	Min	Typ.	Max	Units
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =100μA	30	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J		-	40	-	mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V	-	-	1.0	μA
Gate-Body Leakage Current	I _{GSS}	V _{DS} =0V, V _{GS} =±10V	-	-	±1.0	nA
ON CHARACTERISTICS^{NOTE2}						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	0.8	-	1.6	V
Negative Threshold Temperature Coefficient	V _{GS(th)} / T _J		-	3.4	-	mV/°C
Static Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} =4.0V, I _D =10mA	-	1	1.5	Ω
		V _{GS} =2.5V, I _D =10mA	-	1.5	2	
Forward Transconductance	g _{FS}	V _{DS} =3.0V, I _D =10mA	-	0.33	-	S
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{iss}	V _{GS} =0V, f=1.0MHz, V _{DS} =5V	-	41	-	pF
Output Capacitance	C _{oss}		-	12	-	
Reverse Transfer Capacitance	C _{rss}		-	8.1	-	
SWITCHING CHARACTERISTICS						
Turn-on Delay Time	t _{d(on)}	V _{GS} =4.5V, V _{DD} =5.0V, I _D =0.1A, R _G =50Ω	-	16.7	-	ns
Rise Time	t _r		-	47.9	-	
Turn-Off Delay Time	t _{d(off)}		-	65.1	-	
Fall Time	t _f		-	64.2	-	
SOURCE-DRAIN DIODE CHARACTERISTICS						
Forward Voltage	V _{SD}	V _{GS} =0V, I _{SD} =10mA	-	0.65	0.7	V
Reverse Recovery Time	t _{rr}	V _{GS} =0V, dI _S /dt=8A/μs, I _S =10mA	-	14	-	ns

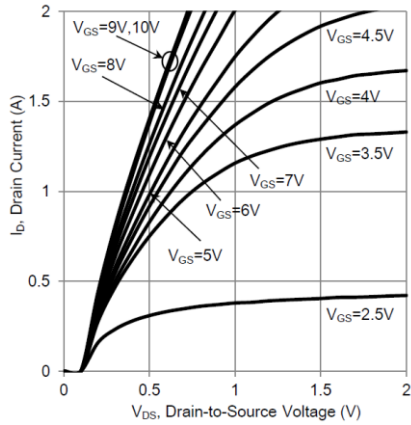
NOTE1: Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

NOTE2: Pulse Test: Pulse Width ≤300μs, Duty Cycle ≤2.0%.

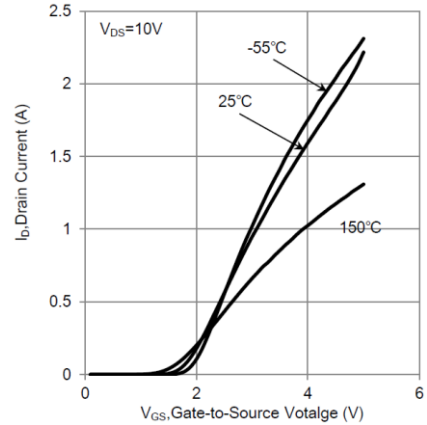


TYPICAL PERFORMANCE CHARACTERISTICS

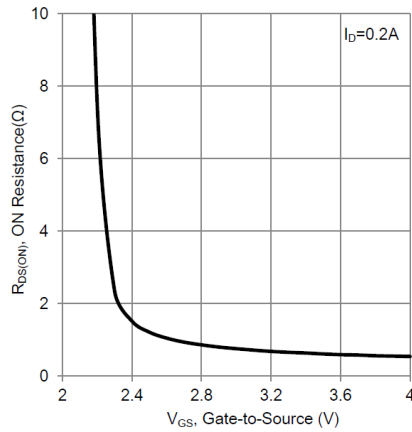
1. On-Region Characteristics



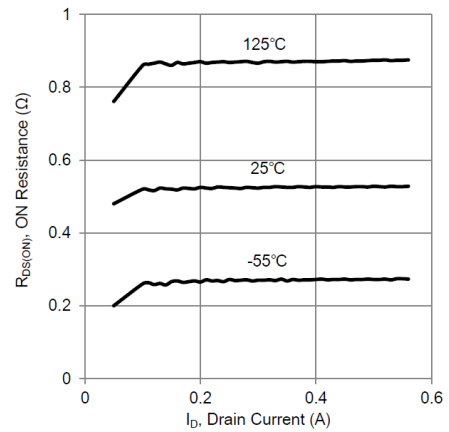
2. Transfer Characteristics



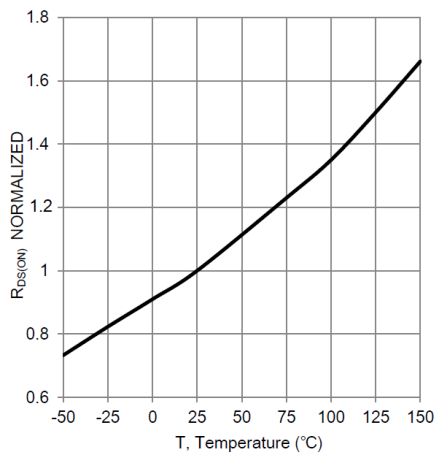
3. $R_{DS(ON)}$ vs. V_{GS}



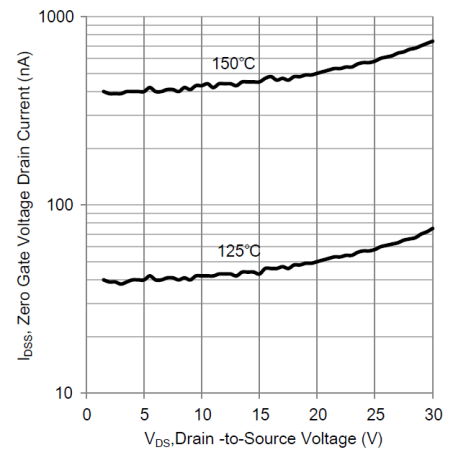
4. $R_{DS(ON)}$ vs. I_D



5. $R_{DS(ON)}$ vs. Temperature

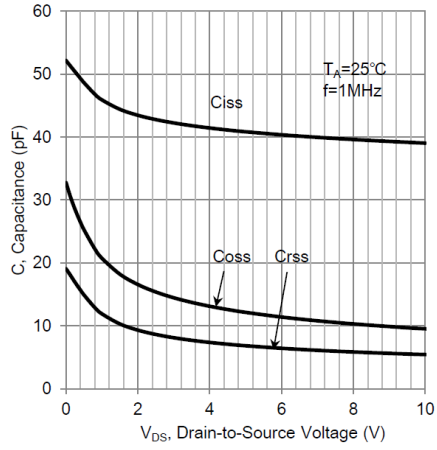


6. I_{DSS} vs. V_{DS}

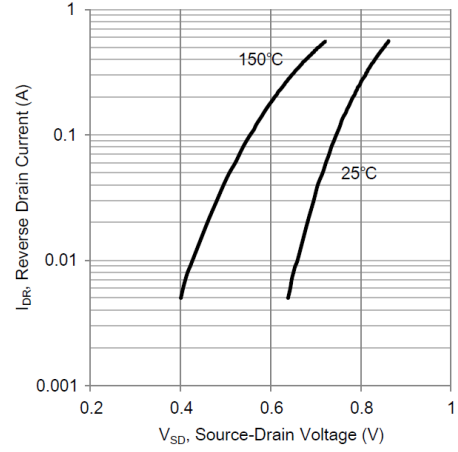




7. Capacitance Variation



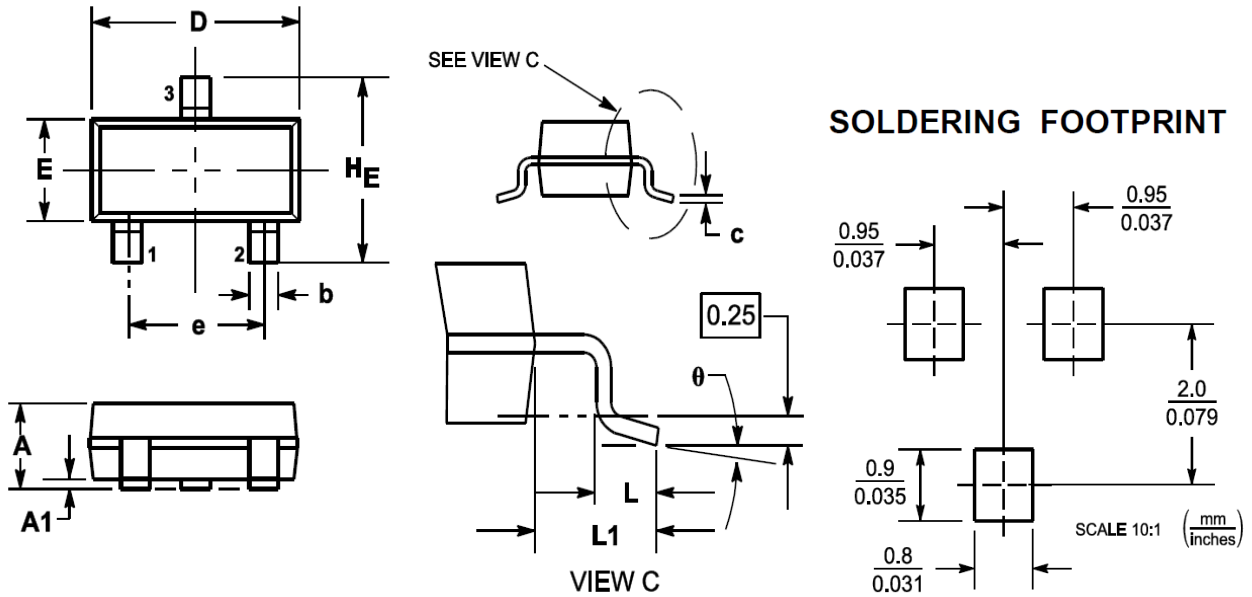
8. Diode Forward Characteristics





PACKAGE INFORMATION

Dimension in SOT-23S Package (Unit: mm)



DIM	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	0.89	1.11	0.035	0.044
A1	0.01	0.10	0.001	0.004
b	0.37	0.50	0.015	0.02
c	0.09	0.18	0.003	0.007
D	2.80	3.04	0.11	0.12
E	1.20	1.40	0.047	0.055
e	1.78	2.04	0.07	0.081
L	0.10	0.30	0.004	0.012
L1	0.35	0.69	0.014	0.029
HE	2.10	2.64	0.083	0.104
θ	0°	10°	0°	10°



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